## **18. TEST PHOTOGRAPHS**

See following Attached Pages for setup photographs.

FCC ID: A3LSMJ737P		HAC (RF EMISSIONS) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename: 1M1802160028-11-R1.A3L	Test Dates: 3/26/2018 - 3/29/2018	DUT Type: Portable Handset		Page 86 of 88
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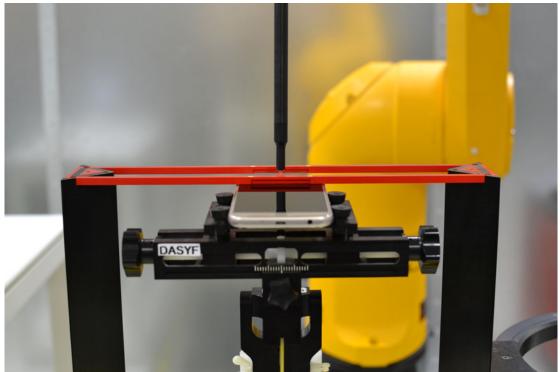


Figure 18-1 Ear Reference Point HAC Phantom Alignment

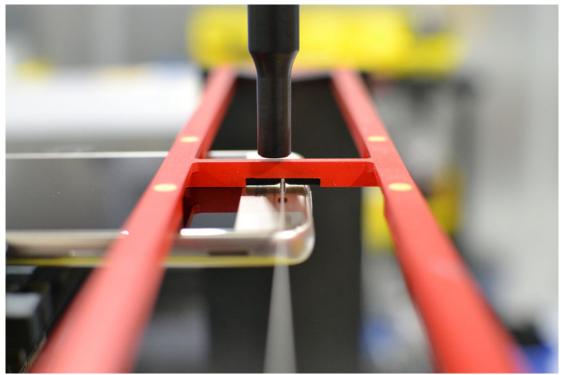
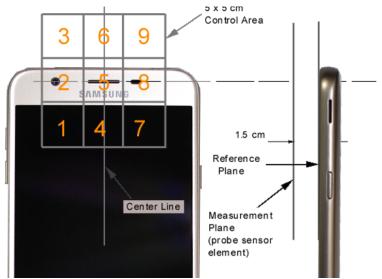


Figure 18-2 HAC Phantom Plane Alignment

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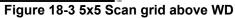




Figure 18-4 E-Field WD Scan overlay

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